Designing an Efficient Hybrid Optical Cavity

Thomas Siday¹, Robert J Thompson¹,², Samuel Glass¹, Ting-Shan Luk³,⁴, John L Reno³,⁴, Igal Brener³,⁴ and Oleg Mitrofanov¹,³
¹Electronic and Electrical Engineering, University College London, London, UK
²London Center for Nanotechnology, University College London, London, WC1H 0AH
³Center for Integrated Technologies, Sandia National Laboratory, Albuquerque, NM 87185, USA
⁴Sandia National Laboratory, Albuquerque, NM 87185, USA

We present an efficient terahertz (THz) detector based on an optically thin hybrid cavity. We use experimental and numerical methods to design efficient detectors, finding a hybrid cavity structure with a photoconductive (PC) layer as thin as 50 nm which absorbs almost 80% of light at the operation wavelength. These optically thin detectors are well suited to near-field microscopy and terahertz component integration.

I. INTRODUCTION

The performance of photoconductive THz detectors based on low temperature grown (LT) GaAs is limited primarily by the properties of the bulk semiconductor material. While the sub-picosecond switching time of LT-GaAs allows for THz detection, the relatively long absorption length when compared to the mean free path of photo-excited carriers limits detection performance, as the majority of photo-excited carriers recombine before being collected at an electrode. The use of plasmonic nanostructured electrodes has been shown to increase the proportion of collected carriers [1]; however, the narrow spacing of the electrodes may lead to increased dark current.

Alternatively, photonic structures trap light within a thin photoconductive layer, effectively reducing the optical absorption length. The mean free path of photo-excited carriers remains constant, resulting in increased carrier collection. A scheme for trapping light within a thin PC layer was recently proposed for application to THz detectors using a hybrid cavity design [2]. The structure is shown in Figure 1(a). A molecular beam epitaxy (MBE) grown LT-GaAs PC layer is situated between a Distributed Bragg Reflector (DBR), consisting of 5 pairs of alternating Alₐ₀.₅₅Gaₐ₀.₄₅As and GaAs layers, and an array of lithographically defined gold nano-antennas, electrically isolated from the PC layer with a thin (15 nm) layer of aluminum oxide.

Here, we use finite-difference time-domain (FDTD) simulations [3] to design efficient hybrid cavity structures. We provide insight into the dependence on nano-antenna length, array periodicity and PC layer thickness. Fabricated hybrid cavity structures are integrated into THz PC detectors and device performance is compared to identical detectors without the nano-antenna array.

II. RESULTS

Figure 1(b, c) shows respectively, numerical and experimental reflectivity and transmission of the hybrid cavity. Without the nano-antenna array, the device acts as a DBR (dashed lines), with high reflectivity and low transmission within the stopband. When the nano-antenna array is introduced (solid lines) the reflectivity is suppressed within the stopband to a minimum of ~5% at the design wavelength (~810 nm), while transmission through the device remains low. This suppression in reflectivity indicates a high absorption resonant mode within the hybrid cavity.

By varying the thickness of the LT-GaAs PC layer, periodic maxima occur at the design wavelength for thicknesses 50 nm, 160 nm, and 270 nm (Fig. 2). The location of these maxima can be approximated analytically with a k-vector condition incorporating the PC layer and DBR:

$$ k = \frac{m_r \pi}{L_{GaAs} n_{GaAs} + m_{DBR} n_{DBR}} $$

Here, $L_{GaAs}$ is the thickness of the PC layer with refractive index $n_{GaAs}$. $m_{DBR}$ is the number of DBR pairs with thickness $L_{DBR}$ and average refractive index $n_{DBR}$. $m_r$ is a half-integer, and represents the resonance mode order of the cavity. Within the DBR stopband (Fig. 1(b)), the k-vector condition agrees with the numerical simulations for $m_r = 5.5, 6.5, \text{ and } 7.5$ (Fig. 2). Optimal PC layer thickness can therefore be expressed as $L_{GaAs} = \left(\frac{1}{4} + \frac{1}{2}N\right) \lambda/n_{GaAs}$ where $N = 0, 1, 2,...$
FDTD simulations predict the length of the nano-antennas affects both the wavelength at which reflections are suppressed, and the efficiency of the suppression (Fig. 3(a)). For experimental confirmation, nano-antenna arrays with different electron beam exposures are fabricated (Fig. 3(b)). Varying the electron beam exposure affects both length and width of the nanoantennas, however only the long axis, parallel to the polarization of the incident light, is critical for device performance.

The wavelength dependence can be explained intuitively by considering the phase of the reflected light. Reflections from the DBR have approximately constant phase across the DBR stopband, whereas the phase of light reflected from the nanoantennas shifts significantly, across the nano-antenna resonance. Reflection is suppressed when the above components interfere destructively. For increasing nano-antenna length, their resonant wavelength decreases, resulting in the dependence seen in Figure 1(c).

By using the optimal antenna length (90 nm), the candidate hybrid cavity designs can be identified with optical absorption 79%, 82% and 83% for PC layer thicknesses 50 nm, 160 nm and 270 nm respectively. The nano-antenna array periodicity was found not to significantly affect hybrid cavity absorption [4] and so was nominally set to 340x250 nm.

A 270 nm hybrid cavity structure was integrated into a photoconductive THz detector, and compared to a similar detector without the nano-antenna array with THz time domain spectroscopy (TDS). Figure 4 shows the peak detected THz field. The peak at $\lambda=815$ nm corresponds to the hybrid cavity mode. Inset is the detected THz waveforms at this wavelength.

Fig. 2. Normalized absorption (defined as $1 - (\text{Reflection} + \text{Transmission})$) for increasing GaAs layer thickness. The dashed lines show the k-vector condition (1) for mode orders $m = 5.5, 6.5$ and 7.5 [4].

Fig. 3. (a) Numerical and (b) Experimental reflectivity spectra for increasing nanoantenna size [4].

Fig. 4. Enhancement in detector sensitivity at different wavelengths. Inset: THz waveforms detected with the nano-antenna array (red line) and without (black line) [4].

The sensitivity enhancement measured using the THz TDS system is not as great as the predictions of the numerical simulations and optical characterization. This is due to significant optical absorption within the DBR, and the nano-antenna array, absorption in which does not contribute to the detected THz signal. Absorption within the DBR can be almost entirely eliminated by replacing the GaAs with low Al content AlGaAs. It is also possible to reduce the nano-antenna absorption by either using a metal with lower loss than gold at the operation wavelength, or by reducing the density of nanoantennas in the array.

III. Summary

In this study, we identify and optimize the various parameters required to develop an efficient THz detector based on an optical hybrid cavity. Several designs are identified, including a structure with a 50 nm PC layer which absorbs almost 80% of incident light. However, the significant absorption within the nano-antenna array and DBR limit device performance when used for THz detection. A device design with reduced parasitic absorption is expected to have significantly increased detector performance.

REFERENCES